

HEXEET[®] Power MOSEET

Features

- Advanced Process Technology
- Ultra Low On-Resistance
- Logic Level Gate Drive
- 150°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

	V _{DSS}	55V				
	R _{DS(on)} typ.	48mΩ				
	max.	60mΩ				
	I _D	5.0A				



G	D	S
Gate	Drain	Source

Bees nort number	Deekege Type	Standard Pack		Orderable Part Number	
Base part number	Package Type	Form	Quantity	Orderable Part Number	
AUIRLL024Z	SOT-223	Tape and Reel	2500	AUIRLL024ZTR	

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units		
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V ②	5.0			
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V ⑦	4.0	А		
I _{DM}	Pulsed Drain Current ①	40			
P _D @T _A = 25°C	Maximum Power Dissipation (PCB Mount) ②	2.8	14/		
P _D @T _A = 25°C	Maximum Power Dissipation (PCB Mount) ®	1.0	W		
	Linear Derating Factor (PCB Mount) ⑦	0.02	W/°C		
V _{GS} Gate-to-Source Voltage		± 16	V		
E _{AS} Single Pulse Avalanche Energy (Thermally Limited) 2		21			
E _{AS (Tested)}	Single Pulse Avalanche Energy (Tested Value) 6	38	mJ		
I _{AR}	Avalanche Current ①	See Fig. 12a, 12b, 15, 16	А		
E _{AR}	Repetitive Avalanche Energy		mJ		
TJ	Operating Junction and	-55 to + 150	°C		
T _{STG}	Storage Temperature Range		C		

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JA}$	Junction-to-Ambient (PCB Mount, steady state) 🗇		45	°C \\ \ \
$R_{ heta JA}$	Junction-to-Ambient (PCB Mount, steady state) ®		120	°C/W

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*Qualification standards can be found at <u>www.infineon.com</u>

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55			V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.049		V/°C	Reference to 25° C, I _D = 1mA
· · ·			48	60		V _{GS} = 10V, I _D = 3.0A ③
R _{DS(on)}	Static Drain-to-Source On-Resistance			80	mΩ	V _{GS} = 5.0V, I _D = 3.0A ③
				100		V _{GS} = 4.5V, I _D = 3.0A ③
V _{GS(th)}	Gate Threshold Voltage	1.0		3.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	7.5		_	S	$V_{DS} = 25V, I_{D} = 3.0A$
1	Drain-to-Source Leakage Current			20		V _{DS} = 55V, V _{GS} = 0V
I _{DSS}				250		V _{DS} = 55V,V _{GS} = 0V,T _J = 125°C
I _{GSS}	Gate-to-Source Forward Leakage			200	-	V _{GS} = 16V
	Gate-to-Source Reverse Leakage			-200	nA	V _{GS} = -16V

Static @ T_J = 25°C (unless otherwise specified)

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Continuous Source Current			1		
	Parameter	Min.	Тур.	Max.	Units	Conditions
Diode Char	racteristics					
Coss eff.	Effective Output Capacitance		93			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 44V \oplus$
C _{oss}	Output Capacitance		53			$V_{GS} = 0V, V_{DS} = 44V, f = 1.0MHz$
C _{oss}	Output Capacitance		220		pF	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C _{rss}	Reverse Transfer Capacitance		36]	<i>f</i> = 1.0MHz
C _{oss}	Output Capacitance		66			V _{DS} = 25V
C _{iss}	Input Capacitance		380			V _{GS} = 0V
t _f	Fall Time		15			V _{GS} = 5.0V ③
t _{d(off)}	Turn-Off Delay Time		20		ns	$R_{G} = 56\Omega$
t _r	Rise Time		33			I _D = 3.0A
t _{d(on)}	Turn-On Delay Time		8.6			$V_{DD} = 28V$
Q _{gd}	Gate-to-Drain Charge		4.0			V _{GS} = 5.0V ③
Q _{gs}	Gate-to-Source Charge		1.5		nC	$V_{DS} = 44V$
Q _g	Total Gate Charge		7.0	11		I _D = 3.0A

	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current			5.0		MOSFET symbol
I _S	(Body Diode)			5.0	^	showing the
	Pulsed Source Current			10	A	integral reverse
I _{SM}	(Body Diode) ①			40		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_{J} = 25^{\circ}C, I_{S} = 3.0A, V_{GS} = 0V @$
t _{rr}	Reverse Recovery Time		15	23	ns	T _J = 25°C ,I _F = 3.0A, V _{DD} = 28V
Q _{rr}	Reverse Recovery Charge		9.1	14	nC	di/dt = 100A/µs
t _{on}	Forward Turn-On Time	Intrinsio	c turn-or	n time is	negligil	ole (turn-on is dominated by LS+LD)

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

O Limited by T_{Jmax}, Starting T_J = 25°C, L = 4.8mH, R_G = 25 Ω , I_{AS} = 3.A. V_{GS} = 10V.Part not recommended for use above this value.

③ Pulse width \leq 1.0ms; duty cycle \leq 2%.

④ C_{oss eff}. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

 $\$ Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.

© This value determined from sample failure population, starting $T_J = 25^{\circ}C$, L = 4.8mH, $R_G = 25\Omega$, $I_{AS} = 3.0A$, $V_{GS} = 10V$.

⑦ When mounted on 1 inch square copper board.

When mounted on FR-4 board using minimum recommended footprint.



VGS 10V 9.0V 7.0V 5.0V 4.5V 4.0V

3.5V 3.0V

тор

воттом

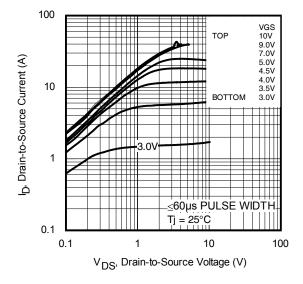
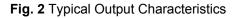


Fig. 1 Typical Output Characteristics

I_D, Drain-to-Source Current (A) 3.0V 1 ≤60µs PULSE WIDTH Tj = 150°C 0.1 0.1 10 100 1 $\mathsf{V}_{DS}\!,$ Drain-to-Source Voltage (V)

100

10



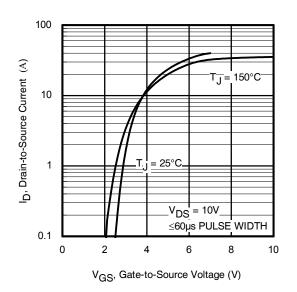


Fig. 3 Typical Transfer Characteristics

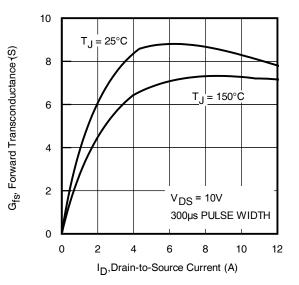
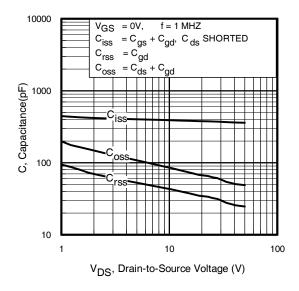
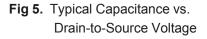


Fig. 4 Typical Forward Trans conductance vs. Drain Current







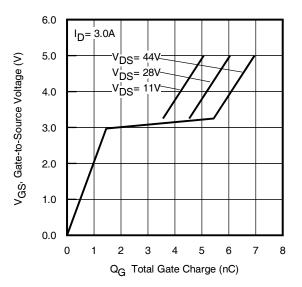
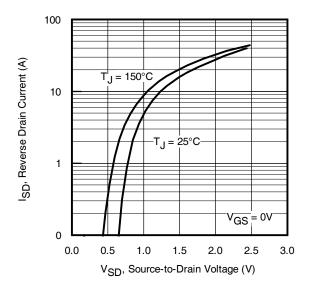
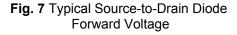


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage





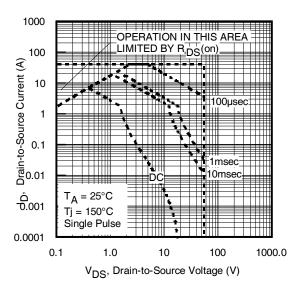


Fig 8. Maximum Safe Operating Area



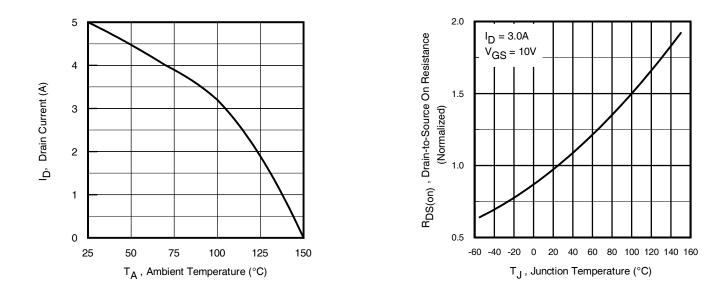
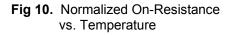


Fig 9. Maximum Drain Current Vs. Ambient Temperature



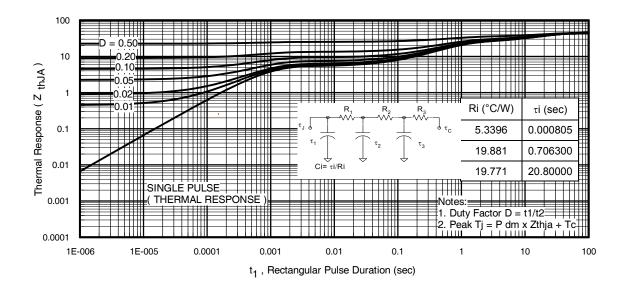


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

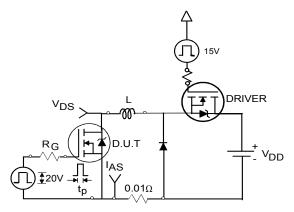


Fig 12a. Unclamped Inductive Test Circuit

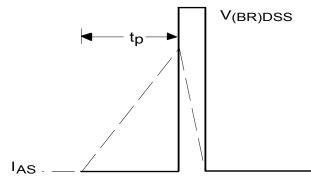
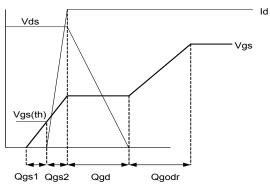
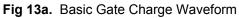


Fig 12b. Unclamped Inductive Waveforms





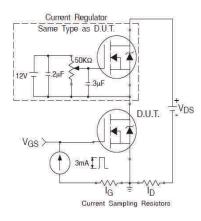


Fig 13b. Gate Charge Test Circuit

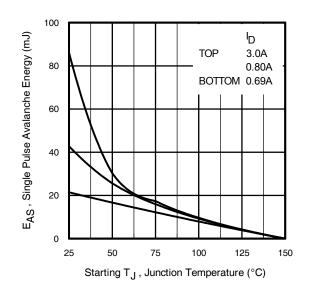


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

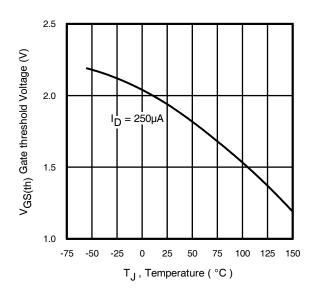


Fig 14. Threshold Voltage vs. Temperature



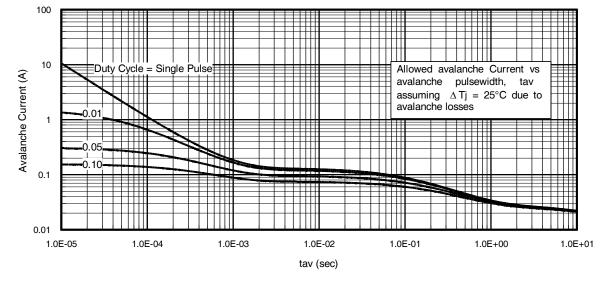
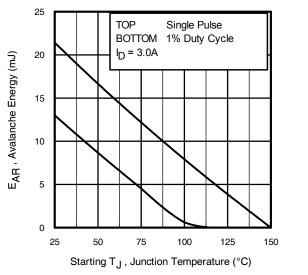
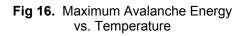


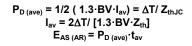
Fig 15. Typical Avalanche Current vs. Pulse width





Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.infineon.com)

- 1. Avalanche failures assumption:
 - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
 - tav = Average time in avalanche.
 - D = Duty cycle in avalanche = tav ·f
 - ZthJC(D, tav) = Transient thermal resistance, see Figures 13)



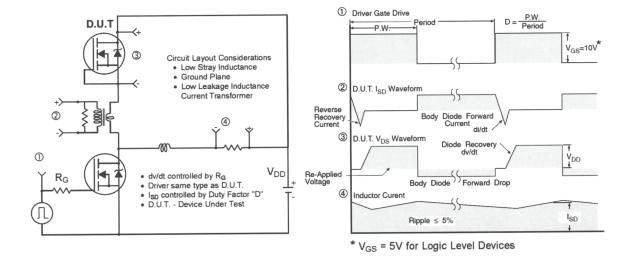


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

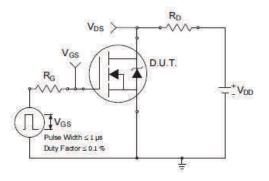


Fig 18a. Switching Time Test Circuit

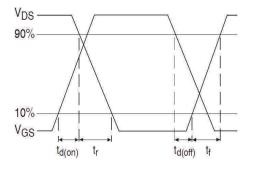
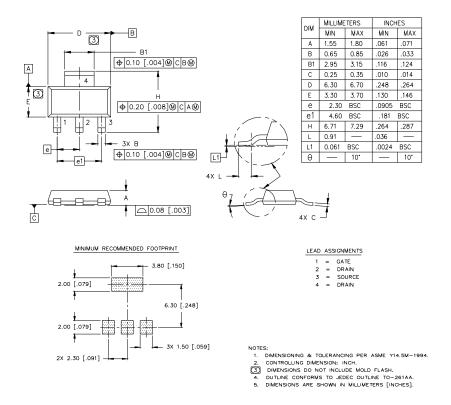


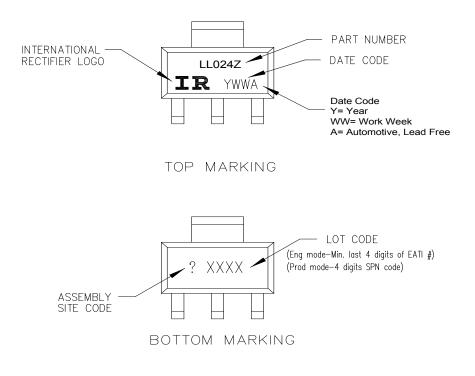
Fig 18b. Switching Time Waveforms



SOT-223 (TO-261AA) Package Outline (Dimensions are shown in millimeters (inches)



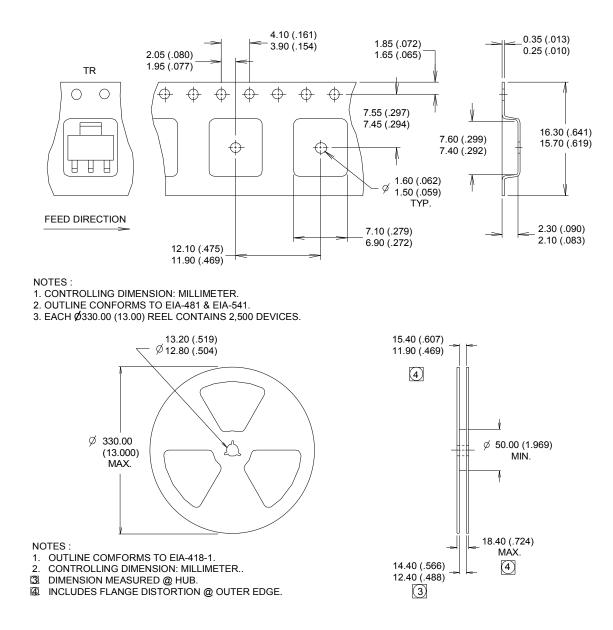
SOT-223(TO-261AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



SOT-223(TO-261AA) Tape and Reel (Dimensions are shown in millimeters (inches)



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive					
		(per AEC-Q101)					
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.					
Moisture	Sensitivity Level	nsitivity Level SOT-223 MSL1					
		Class M1B (+/- 100V) [†]					
	Machine Model	AEC-Q101-002					
	Lives are Deady. Madel	Class H0 (+/- 250V) [†]					
ESD	Human Body Model	AEC-Q101-001					
	Charged Device Medal	Class C5 (+/- 1125V) [†]					
	Charged Device Model		AEC-Q101-005				
RoHS Cor	npliant	Yes					

+ Highest passing voltage.

Revision History

Date	Comments				
3/26/2014	 Added "Logic Level Gate Drive" bullet in the features section on page 1 Updated part marking on page 9 Updated data sheet with new IR corporate template 				
10/29/2015	 Updated datasheet with corporate template Corrected ordering table on page 1. 				

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